Preferred Device

## Sensitive Gate Silicon Controlled Rectifiers

## **Reverse Blocking Thyristors**

Designed for high volume, low cost, industrial and consumer applications such as motor control; process control; temperature, light and speed control.

### Features

- Small Size
- Passivated Die for Reliability and Uniformity
- Low Level Triggering and Holding Characteristics
- Available in Two Package Styles Surface Mount Lead Form – Case 369C Miniature Plastic Package – Straight Leads – Case 369
- Epoxy Meets UL 94 V-0 @ 0.125 in
- ESD Ratings: Human Body Model, 3B > 8000 V Machine Model, C > 400 V
- Pb–Free Packages are Available

### **MAXIMUM RATINGS** (T<sub>J</sub> = $25^{\circ}$ C unless otherwise noted)

Rating	Symbol	Value	Unit
Peak Repetitive Off–State Voltage (Note 1) (T <sub>J</sub> = -40 to 110°C, Sine Wave, 50 Hz to 60 Hz) MCR8DSM MCR8DSN	V <sub>DRM,</sub> V <sub>RRM</sub>	600 800	V
On-State RMS Current (180° Conduction Angles; T <sub>C</sub> = 90°C)	I <sub>T(RMS)</sub>	8.0	A
Average On-State Current (180° Conduction Angles; T <sub>C</sub> = 90°C)	I <sub>T(AV)</sub>	5.1	A
Peak Non-Repetitive Surge Current (1/2 Cycle, Sine Wave 60 Hz, $T_J = 110^{\circ}$ C)	I <sub>TSM</sub>	90	A
Circuit Fusing Consideration (t = 8.3 msec)	l <sup>2</sup> t	34	A <sup>2</sup> sec
Forward Peak Gate Power (Pulse Width $\leq$ 10 $\mu$ sec, T <sub>C</sub> = 90°C)	P <sub>GM</sub>	5.0	W
Forward Average Gate Power (t = 8.3 msec, $T_C$ = 90°C)	P <sub>G(AV)</sub>	0.5	W
Forward Peak Gate Current (Pulse Width $\leq$ 10 $\mu$ sec, T <sub>C</sub> = 90°C)	I <sub>GM</sub>	2.0	A
Operating Junction Temperature Range	TJ	-40 to 110	°C
Storage Temperature Range	T <sub>stg</sub>	-40 to 150	°C

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

 V<sub>DRM</sub> and V<sub>RRM</sub> for all types can be applied on a continuous basis. Ratings apply for negative gate voltage; positive gate voltage shall not be applied concurrent with negative potential on the anode. Blocking voltages shall not be tested with a constant current source such that the voltage ratings of the device are exceeded.



### **ON Semiconductor®**

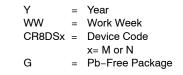
http://onsemi.com

SCRs 8 AMPERES RMS 600 – 800 VOLTS



MARKING DIAGRAM





PIN ASSIGNMENT				
1	Cathode			
2	Anode			
3	Gate			
4	Anode			

### **ORDERING INFORMATION**

See detailed ordering and shipping information in the package dimensions section on page 2 of this data sheet.

Preferred devices are recommended choices for future use and best overall value.

### THERMAL CHARACTERISTICS

Characteristic	Symbol		Max		Unit	
Thermal Resistance – Junction-to-Case – Junction-to-Ambient – Junction-to-Ambient (Note 2)	R <sub>θJC</sub> R <sub>θJA</sub> R <sub>θJA</sub>	2.2 88 80			°C/W	
Maximum Lead Temperature for Soldering Purposes 1/8" fr	TL	260			°C	
ELECTRICAL CHARACTERISTICS (TJ = 25°C unless	s otherwise noted)					
Characteristics		Symbol	Min	Тур	Max	Unit
DFF CHARACTERISTICS				-		-
Peak Repetitive Forward or Reverse Blocking Current ( $V_{AK}$ = Rated $V_{DRM}$ or $V_{RRM}$ ; $R_{GK}$ = 1.0 k $\Omega$ ) (Note 3)	T <sub>J</sub> = 25°C T <sub>J</sub> = 110°C	I <sub>DRM</sub> I <sub>RRM</sub>			10 500	μA
ON CHARACTERISTICS						
Peak Reverse Gate Blocking Voltage ( $I_{GR}$ = 10 $\mu$ A)		V <sub>GRM</sub>	10	12.5	18	V
Peak Reverse Gate Blocking Current (V <sub>GR</sub> = 10 V)	I <sub>RGM</sub>	-	-	1.2	μA	
Peak Forward On-State Voltage (Note 4) (I <sub>TM</sub> = 16 A)	V <sub>TM</sub>	-	1.4	1.8	V	
Gate Trigger Current (Continuous dc) (Note 5) $(V_D = 12 \text{ V}, \text{ R}_L = 100 \Omega)$	T <sub>J</sub> = 25°C T <sub>J</sub> = -40°C	I <sub>GT</sub>	5.0 _	12 -	200 300	μA
Gate Trigger Voltage (Continuous dc) (Note 5) $(V_D = 12 \text{ V}, \text{ R}_L = 100 \Omega)$	T <sub>J</sub> = 25°C T <sub>J</sub> = −40°C T <sub>J</sub> = 110°C	V <sub>GT</sub>	0.45 _ 0.2	0.65 _ _	1.0 1.5 -	V
Holding Current (V <sub>D</sub> = 12 V, Initiating Current = 200 mA, R <sub>GK</sub> = 1 k $\Omega$ )	T <sub>J</sub> = 25°C T <sub>J</sub> = -40°C	Ι <sub>Η</sub>	0.5 _	1.0 _	6.0 10	mA
Latching Current (V <sub>D</sub> = 12 V, I <sub>G</sub> = 2.0 mA, R <sub>GK</sub> = 1 k $\Omega$ )	T <sub>J</sub> = 25°C T <sub>J</sub> = -40°C	۱ <sub>L</sub>	0.5	1.0 _	6.0 10	mA
Total Turn–On Time (Source Voltage = 12 V, $R_S = 6.0 \text{ k}\Omega$ , $I_T = 16 \text{ A(pk)}$ , $R_{GF}$ ( $V_D = \text{Rated V}_{DRM}$ , Rise Time = 20 ns, Pulse Width = 1	tgt	-	2.0	5.0	μs	

Critical Rate of Rise of Off-State Voltage	dv/dt				V/μs
(V <sub>D</sub> = 0.67 X Rated V <sub>DRM</sub> , Exponential Waveform,		2.0	10	-	-
$R_{GK} = 1.0 \text{ k}\Omega, T_{J} = 110^{\circ}\text{C}$					

2. Surface mounted on minimum recommended pad size.

3. Ratings apply for negative gate voltage or  $R_{GK} = 1.0 \text{ k}\Omega$ . Devices shall not have a positive gate voltage concurrently with a negative voltage on the anode. Devices should not be tested with a constant current source for forward and reverse blocking capability such that the voltage applied exceeds the rated blocking voltage. 4. Pulse Test; Pulse Width  $\leq$  2.0 msec, Duty Cycle  $\leq$  2%. 5. R<sub>GK</sub> current not included in measurements.

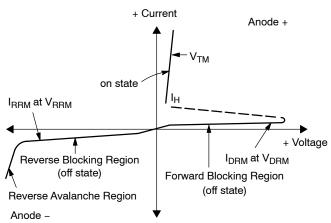
### **ORDERING INFORMATION**

Device	Package	Shipping <sup>†</sup>
MCR8DSMT4	DPAK	
MCR8DSMT4G	DPAK (Pb-Free)	0500 / Terre & Deel
MCR8DSNT4	DPAK	2500 / Tape & Reel
MCR8DSNT4G	DPAK (Pb-Free)	

+For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

### Voltage Current Characteristic of SCR

Symbol	Parameter
V <sub>DRM</sub>	Peak Repetitive Off-State Forward Voltage
I <sub>DRM</sub>	Peak Forward Blocking Current
V <sub>RRM</sub>	Peak Repetitive Off-State Reverse Voltage
I <sub>RRM</sub>	Peak Reverse Blocking Current
V <sub>TM</sub>	Peak On-State Voltage
I <sub>H</sub>	Holding Current



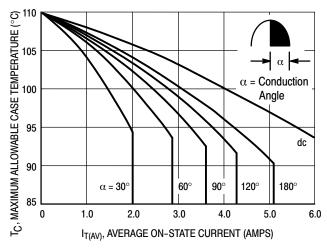


Figure 1. Average Current Derating

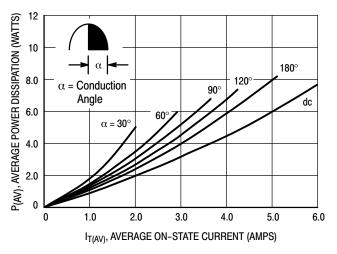


Figure 2. On-State Power Dissipation

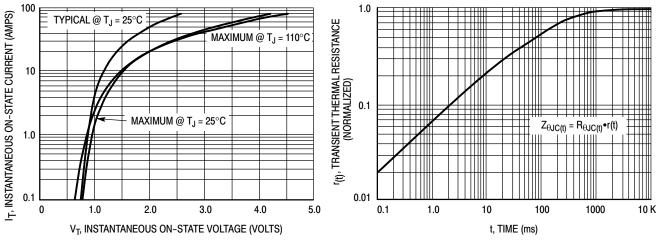




Figure 4. Transient Thermal Response

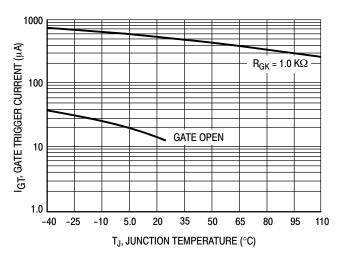


Figure 5. Typical Gate Trigger Current versus Junction Temperature

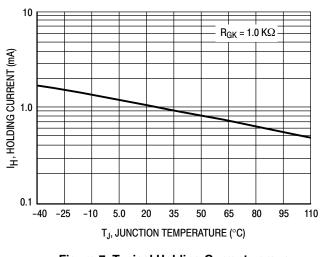


Figure 7. Typical Holding Current versus Junction Temperature

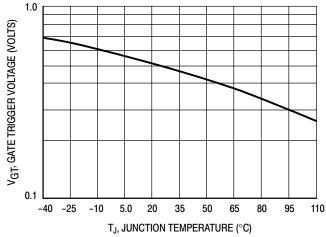
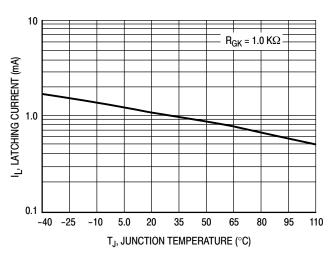


Figure 6. Typical Gate Trigger Voltage versus Junction Temperature





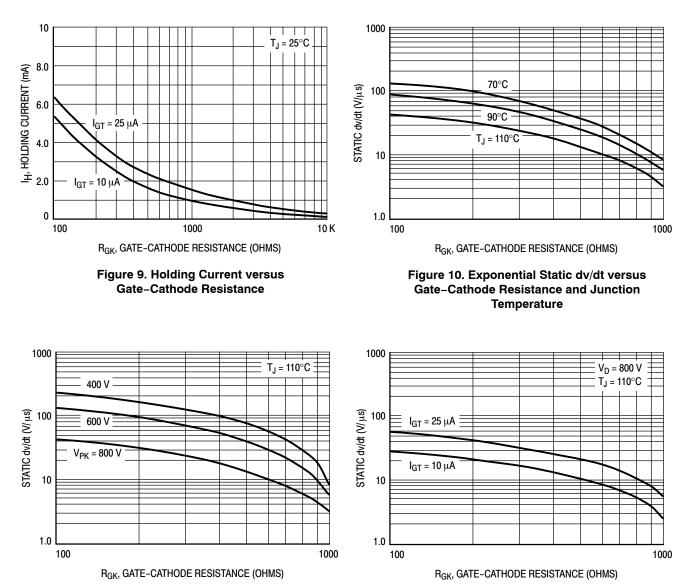
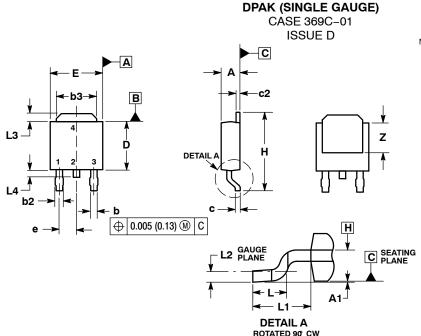


Figure 11. Exponential Static dv/dt versus Gate-Cathode Resistance and Peak Voltage

Figure 12. Exponential Static dv/dt versus Gate–Cathode Resistance and Gate Trigger Current Sensitivity

#### PACKAGE DIMENSIONS



NOTES:

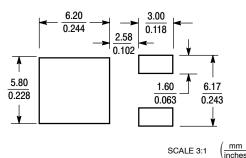
- 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994. CONTROLLING DIMENSION: INCHES.
- THERMAL PAD CONTOUR OPTIONAL WITHIN DI-MENSIONS b3, L3 and Z.
- DIMENSIONS D AND E DO NOT INCLUDE MOLD FLASH, PROTRUSIONS, OR BURRS. MOLD FLASH, PROTRUSIONS, OR GATE BURRS SHALL NOT EXCEED 0.000 INCHES PER SIDE. 4
- DIMENSIONS D AND E ARE DETERMINED AT THE OUTERMOST EXTREMES OF THE PLASTIC BODY. 6 DATUMS A AND B ARE DETERMINED AT DATUM
- PLANE H

	INCHES		MILLIMETER		
DIM	MIN	MAX	MIN	MAX	
Α	0.086	0.094	2.18	2.38	
A1	0.000	0.005	0.00	0.13	
b	0.025	0.035	0.63	0.89	
b2	0.030	0.045	0.76	1.14	
b3	0.180	0.215	4.57	5.46	
с	0.018	0.024	0.46	0.61	
c2	0.018	0.024	0.46	0.61	
D	0.235	0.245	5.97	6.22	
Е	0.250	0.265	6.35	6.73	
е	0.090	0.090 BSC		BSC	
Н	0.370	0.410	9.40	10.41	
L	0.055	0.070	1.40	1.78	
L1	0.108	REF	2.74 REF		
L2	0.020	BSC	0.51	BSC	
L3	0.035	0.050	0.89	1.27	
L4		0.040		1.01	
Ζ	0.155		3.93		

STYLE 4: PIN 1. CATHODE 2. ANODE З. GATE

4. ANODE

#### SOLDERING FOOTPRINT\*



\*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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